FCC PART 90 TYPE APPROVAL EMI MEASUREMENT AND TEST REPORT

For

Shenzhen HYT Science & Technology Co., Ltd

HYT Tower, Shenzhen Hi-Tech Industrial Park North, Beihuan Rd., Nanshan District, Shenzhen, P.R.C.

FCC ID: R74TC-1688P

May 15, 2006

This Report Concerns: **Equipment Type:** Two-way radio Original Report Charm? Pery **Test Engineer:** Charmi Peng **Report No.:** RSZ06042002 **Test Date:** May 11-15, 2006 Reviewed By: Chris Zeng **Prepared By:** Bay Area Compliance Lab Corp. (ShenZhen) 6/F, the 3rd Phase of WanLi Industrial Building, ShiHua Road, FuTian Free Trade Zone, ShenZhen, Guangdong 518038, P.R.China Tel: +86-755-33320018

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Note: The test report is specially limited to the above company and this particular sample only. It may not be duplicated without prior written consent of Bay Area Compliance Lab Corp. (ShenZhen). This report **must not** be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST or any agency of the US Government.

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GENERAL INFORMATION

Product Description for Equipment Under Test (EUT)

The *Shenzhen HYT Science & Technology Co., Ltd*'s product, model number: TC-1688P or the "EUT" as referred to in this report is a Two-way radio. The EUT is measured approximately 5 cm L x 3 cmW x 16 cmH, rated input voltage: DC 3.6 V battery.

* The test data gathered are from production sample, serial number: 0604037. Provided by the manufacturer, we received the EUT on 2006-4-20

Objective

This Type approval report is prepared on behalf of *Shenzhen HYT Science & Technology Co., Ltd* in accordance with Part 2, and Part 90 of the Federal Communication Commissions rules.

Related Submittal(s)/Grant(s)

No related submittal(s).

Test Methodology

All tests and measurements indicated in this document were performed in accordance with the Code of federal Regulations Title 47 Part 2, Sub-part J as well as the following individual parts:

Part 90 - Private Land Mobile Radio Service

Applicable Standards: TIA EIA 137-A, TIA EIA 98-C, TIA603-C and ANSI 63.4-2003, American National Standard for Method of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

All emissions measurement was performed and Bay Area Compliance Lab Corp. (ShenZhen). The radiated testing was performed at an antenna-to-EUT distance of 3 meters.

Test Facility

The Test site used by Bay Area Compliance Lab Corp. (ShenZhen) to collect test data is located in the 6/F, the 3rd Phase of WanLi Industrial Building, ShiHua Road, FuTian Free Trade Zone, ShenZhen, Guangdong 518038, P.R.China.

Test site at Bay Area Compliance Lab Corp. (ShenZhen) has been fully described in reports submitted to the Federal Communication Commission (FCC). The details of these reports have been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on November 04, 2004. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-2003.

The Federal Communications Commission has the reports on file and is listed under FCC Registration No.: 382179 and Industrial Canada registration test site No.: 5500A. The test site has been approved by the FCC for public use and is listed in the FCC Public Access Link (PAL) database.

Additionally, Bay Area Compliance Lab Corp. (ShenZhen) is a National Institute of Standards and Technology (NIST) accredited laboratory, under the National Voluntary Laboratory Accredited Program (Lab Code 200707-0). The current scope of accreditations can be found at http://ts.nist.gov/ts/htdocs/210/214/scopes/2007070.htm

Local Support Equipment List and Details

Manufacturer	Description	Model	Serial Number	FCC ID
NANYAN	Audio Generator	NY2201	007727	

SYSTEM TEST CONFIGURATION

Description of Test Configuration

The system was configured for testing in a typical fashion (as normally used by a typical user).

Equipment Modifications

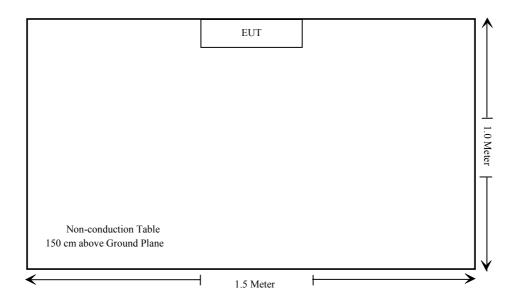
Bay Area Compliance Lab Corp. (ShenZhen) has not done any modification on the EUT.

Configuration of Test Setup



Lie Side Stand

Block Diagram of Test Setup



SUMMARY OF TEST RESULTS

FCC RULES	DESCRIPTION OF TEST	RESULT
§1.1307	RF Exposure	Compliant
\$2.1046, \$90.205	RF Output Power	Compliant
\$2.1047 \$90.207	Modulation Characteristic	Compliant
§2.1049, §90.209	Occupied Bandwidth	Compliant
\$2.1053 \$90.210	Spurious Radiated Emissions	Compliant*
\$ 2.1055 \$ 90.213	Frequency stability	Compliant
§ 90.214	Transient Frequency Behavior	Compliant

^{*} Within the measurement uncertainty

§1.1307(b) (1) RF EXPOSURE

Standard Applicable

According to § 1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensure that the public is not exposed to radio frequency energy level in excess of the Commission's guideline.

According to FCC Exclusion list, In the following table, fGHz is mid-band frequency in GHz, and d is the distance to a person'sbody, excluding hands, wrists, feet, and ankles.

Exposure category	low threshold	high threshold
general population	$(60/f_{GHz}) \text{ mW}, d < 2.5 \text{ cm}$ $(120/f_{GHz}) \text{ mW}, d \ge 2.5 \text{ cm}$	$(900/f_{GHz})$ mW, $d < 20$ cm
occupational	$(375/f_{GHz})$ mW, $d \le 2.5$ cm $(900/f_{GHz})$ mW, $d \ge 2.5$ cm	$(2250/f_{GHz})$ mW, $d \le 20$ cm

Routine SAR evaluation refers to that specifically required by § 2.1093, using measurements or computer simulation. When routine SAR evaluation is not required, portable transmitters with output power greater than the applicable low threshold require SAR evaluation to qualify for TCB approval.

Measurement Result:

This is a portable device and the Max peak output power is 179mW<1616mW=(375/0.464GHz)mW*2

The SAR measurement is not necessary.

§2.1046, and §90.205 - RF OUTPUT POWER

Applicable Standard

According to FCC §2.1046, and §90.205, maximum ERP is dependent upon the station's antenna HAAT and required service area.

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
SUNOL SCIENCES	Horn Antenna	DRH-118	A052604	2005-7-20	2006-7-20
SUNOL SCIENCES	Broadband Antenna	JB1	A040904-1	2006-4-28	2007-4-28
SUNOL SCIENCES	Broadband Antenna	JB1	A040904-2	2006-4-28	2007-4-28
Agilent	Spectrum Analyzer	8564E	3943A01781	2005-12-8	2006-12-08
HP	Signal Generator	HP8657A	2849U00982	2006-2-28	2007-2-28
Giga-tronics	Signal Generator	1026	270801	2006-2-28	2007-2-28
A.H. System	Horn Antenna	SAS- 200/571	135	2006-4-28	2007-4-28

^{*} Statement of Tractability: Bay Area Compliance Lab Corp. (ShenZhen) attests that all calibrations have been performed per the NVLAP requirements, traceable to NIST.

Test Procedure

The transmitter was placed on a wooden turntable, and it was transmitting into a non-radiating load, which was also placed on the turntable.

The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and polarization as well as EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. The test was performed by placing the EUT on 3-orthogonal axis.

The frequency range up to teeth harmonic of the fundamental frequency was investigated.

Remove the EUT and replace it with substitution antenna. A signal generator was connected to the substitution antenna by a non-radiating cable. The absolute levels of the spurious emissions were measured by the substitution.

Spurious emissions in dB = 10 1g (TXpwr in Watts/0.001)-the absolute level

Spurious attenuation limit in $dB = 50 + 10 \text{ Log}_{10}$ (power out in Watts) for EUT with a 12.5 KHz channel bandwidth.

Test Data

Environmental Conditions

Temperature:	25 ° C
Relative Humidity:	50%
ATM Pressure:	1005mbar

The testing was performed by Charmi Peng on 2006-5-11.

Test Result: Pass

Test Mode: Transmitting

Indica	ated	Table	Te Ante		Subs	stituted		Antenna		Absolute Level	FCC
Frequency MHz	Ampl dBuV/m					Level dBm	Polar H/V	Gain Correction	Cable Loss dB	dBm	Output power W
	CH2										
464.5125	97.61	270	1.0	Н	464.5125	22.3	Н	0	5.07	17.23	0.053
464.5125	107.74	45	1.2	V	464.5125	27.6	V	0	5.07	22.53	0.179

§2.1047, and §90.207 - MODULATION CHARACTERISTIC

Applicable Standard

§2.1047 & §90.207:

- (a) Equipment which utilizes voice modulated communication shall show the frequency response of the audio modulating circuit over a range of 100 to 5000 Hz. for equipment which is required to have a low pass filter, the frequency response of the filter, or all of the circuitry installed between the modulation limited and the modulated stage shall be supplied.
- (b) Equipment which employs modulation limiting, a curve showing the percentage of modulation versus the modulation input voltage shall be supplied.

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
Rohde&Schwarz	Spectrum Analyzer	FSEM30	849720/019	2005-12-21	2006-12-21
НР	Modulation Analyzer	8901B	3438A05208	2006-2-28	2007-2-28
NANYAN	Audio Generator	NY2201	019829	2005-12-23	2006-12-23

^{*} Statement of Traceability: Bay Area Compliance Lab Corp. (ShenZhen) attests that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

Test Procedure

Test Method: TIA/EIA-603 2.2.3

Test Data

Environmental Conditions

Temperature:	25 ° C
Relative Humidity:	50%
ATM Pressure:	1005mbar

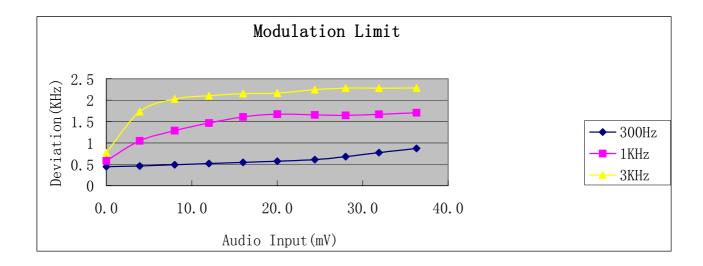
The testing was performed by Charmi Peng on 2006-5-11.

Test Result: Pass

Test Mode: Transmitting

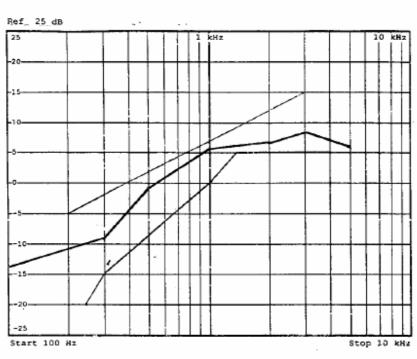
For 12.5 kHz Channel Bandwidth:

Audio Input (mV)	300Hz Deviation (kHz)	1kHz Deviation (kHz)	3kHz Deviation (kHz)
0.0	0. 443	0. 581	0.768
4.0	0.459	1.051	1.732
8.0	0.489	1. 288	2. 027
12.0	0. 519	1.465	2. 101
16. 0	0. 542	1.607	2. 152
20.0	0. 571	1. 671	2. 165
24. 0	0.608	1. 653	2. 246
28.0	0.678	1.645	2. 283
32.0	0.772	1.669	2. 282
36.0	0.871	1. 705	2. 284

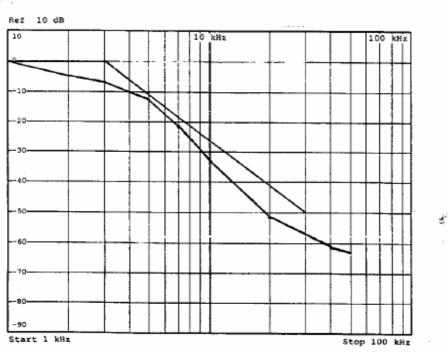


Audio Low Filter Characteristic









§2.1049, and § 90.209 - OCCUPIED BANDWIDTH

Applicable Standard

§2.1049, §90.209 and §90.210

Emission Mask D—12.5 kHz channel bandwidth equipment. For transmitters designed to operate with a 12.5 kHz channel bandwidth, any emission must be attenuated below the power (P) of the highest emission contained within the authorized bandwidth as follows:

- 1) For any frequency removed from the center of the authorized bandwidth f_0 to 5.625kHz removed from f_0 , 0dB.
- 2) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (f_d in kHz) of more than 5.626kHz but no more than 12.5kHz, at least 7.27 (f_d –2.88kHz) dB.
- 3) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (f_d in kHz) of more than 12.5kHz at least:

50+10logP=50+10log(0.87)=49.40dB

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
Rohde&Schwarz	EMI Test Receiver	ESCI	100035	2005-8-17	2006-8-17
HP	Modulation Analyzer	8901B	3438A05208	2006-2-28	2007-2-28
NANYAN	Audio Generator	NY2201	019829	2005-12-23	2006-12-23

^{*} Statement of Traceability: Bay Area Compliance Lab Corp. (ShenZhen) attests that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

Test Procedure

The RF output of the transmitter was connected to the input of the spectrum analyzer through sufficient attenuation.

The resolution bandwidth of the spectrum analyzer was set at 300 Hz and the spectrum was recorded in the frequency band ± 50 KHz from the carrier frequency.

Test Data

Environmental Conditions

Temperature:	25 ° C
Relative Humidity:	50%
ATM Pressure:	1005mbar

The testing was performed by Charmi Peng on 2006-5-11.

Test Result: Pass.

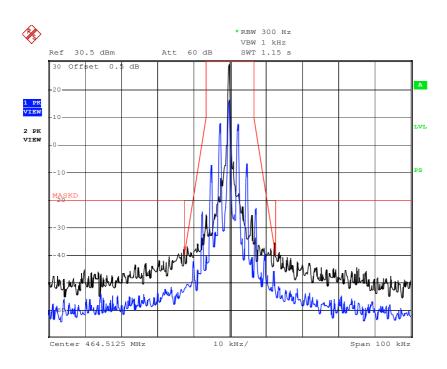
Test Mode: Transmitting

Please refer to the hereinafter plots.

Emission Designator:

For 12.5KHz Channel Spacing: 2M+2D = 2x3+2x2.5 = 11K0F3E

Emission Mask D for 12.5 KHz Channel Bandwidth



HYT Two-way radio M/N:TC-1688P Emission mask Narrowband Mask

D

Date: 11.MAY.2006 14:18:27

§2.1053 and §90.210 - RADIATED SPURIOUS EMISSION

Applicable Standard

§2.1053 and §90.210

Test Equipment List and Details

Manufacturer	- 0P		Serial Number	Calibration Date	Calibration Due Date
SUNOL SCIENCES	Horn Antenna	DRH-118	A052604	2005-7-20	2006-7-20
SUNOL SCIENCES	Broadband Antenna	JB1	A040904-1	2006-4-28	2007-4-28
SUNOL SCIENCES	Broadband Antenna	JB1	A040904-2	2006-4-28	2007-4-28
Agilent	Spectrum Analyzer	8564E	3943A01781	2005-12-08	2006-12-08
HP	Signal Generator	HP8657A	2849U00982	2006-2-28	2007-2-28
Giga-tronics	Signal Generator	1026	270801	2006-2-28	2007-2-28
A.H. System	Horn Antenna	SAS- 200/571	135	2006-4-28	2007-4-28

^{*} Statement of Traceability: Bay Area Compliance Lab Corp. (ShenZhen) attests that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

Test Procedure

The transmitter was placed on a wooden turntable, and it was transmitting into a non-radiating load, which was also placed on the turntable.

The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and polarization as well as EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. The test was performed by placing the EUT on 3-orthogonal axis.

The frequency range up to teeth harmonic of the fundamental frequency was investigated.

Remove the EUT and replace it with substitution antenna. A signal generator was connected to the substitution antenna by a non-radiating cable. The absolute levels of the spurious emissions were measured by the substitution.

Spurious emissions in dB =10 1g (TXpwr in Watts/0.001)-the absolute level

Spurious attenuation limit in $dB = 50 + 10 \text{ Log}_{10}$ (power out in Watts) for EUT with a 12.5KHz channel bandwidth.

Test Results Summary

For Narrowband 12.5 kHz: -1.63 dB at 1858.05 MHz.

Test Data

Environmental Conditions

Temperature:	25 ° C
Relative Humidity:	50%
ATM Pressure:	1005mbar

The testing was performed by Simon Mo on 2006-5-11.

Test Mode: Transmitting
For Narrowband 12.5 kHz:

Indica	ited	Table	Te Ante		Subs	stituted		Antenna		Absolute Level	F	-CC
Frequency MHz	Ampl dBuV/m	Angle	Height	Polar	Frequency MHz		Polar H/V	Gain Correction	Cable Loss dB	dBm	Limit dBm	Margin
	CH2											
1858.05	78.17	60	1.2	V	1858.05	-17.3	V	6.1	0.43	-21.63	-20	-1.63*
929.025	50.32	45	1.0	V	929.025	-11.3	V	0	7.62	-21.92	-20	-1.92*
1393.5375	83.83	45	1.0	V	1393.5375	-28.1	V	6.5	0.33	-21.93	-20	-1.93*
3251.5875	74.50	45	1.0	Н	3251.5875	-30.2	Н	6.9	0.57	-23.87	-20	-3.87*
3716.1	73.67	60	1.2	Н	3716.1	-30.4	Н	6.6	0.67	-24.47	-20	-4.47
3251.5875	72.50	60	1.0	V	3251.5875	-31.0	V	6.9	0.57	-24.67	-20	-4.67
4180.6125	69.50	35	3.0	Н	4180.6125	-32.5	Н	7.0	0.64	-26.14	-20	-6.14
1858.05	79.50	45	1.2	Н	1858.05	-32.4	Н	6.1	0.43	-26.73	-20	-6.73
2322.5625	71.50	90	1.0	V	2322.5625	-36.0	V	7.0	0.32	-29.32	-20	-9.32
1393.5375	76.17	60	1.0	Н	1393.5375	-36.0	Н	6.5	0.33	-29.83	-20	-9.83
929.025	42.08	90	1.0	Н	929.025	-22.9	Н	0	7.62	-30.52	-20	-10.52
4180.6125	65.67	180	1.2	V	4180.6125	-38.4	V	7.0	0.64	-32.04	-20	-12.04
2787.075	67.83	180	1.0	V	2787.075	-39.3	V	7.4	0.51	-32.41	-20	-12.41
3716.1	67.00	45	1.2	V	3716.1	-39.4	V	6.6	0.67	-33.47	-20	-13.47
2787.075	64.00	45	1.0	Н	2787.075	-42.8	Н	7.4	0.51	-35.91	-20	-15.91
2322.5625	65.17	180	1.2	Н	2322.5625	-43.2	Н	7.0	0.32	-36.52	-20	-16.52
4645.125	53.83	35	1.0	Н	4645.125	-52.3	Н	8.3	0.68	-44.68	-20	-24.68
4645.125	51.33	45	1.0	V	4645.125	-55.7	V	8.3	0.68	-48.08	-20	-28.08

^{*} Within measurement uncertainty.

§2.1055 (d) and §90.213- FREQUENCY STABILITY

Applicable Standard

§2.1055 (d)

\$90.213

For output power > 2 watts, the limit is 5.0ppm.

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
NANYAN	Audio Generator	NY2201	019829	2005-12-23	2006-12-23
Hewlett-Packard	Frequency Counter	5342A	2317A08289	2006-1-26	2007-1-26

^{*} Statement of Traceability: Bay Area Compliance Lab Corp. (ShenZhen) attests that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

Test Procedure

Frequency Stability vs. Temperature: The equipment under test was connected to an external DC power supply and the RF output was connected to a f Spectrum Analyzer via feed-through attenuators. The EUT was placed inside the temperature chamber. The DC leads and RF output cable exited the chamber through an opening made for the purpose.

After the temperature stabilized for approximately 20 minutes, the frequency output was recorded from the Spectrum Analyzer.

Frequency Stability vs. Voltage: An external variable DC power supply Source. The voltage was set to 115% of the nominal value and was then decreased until the transmitter light no longer illuminated; i.e., the end point. The output frequency was recorded for each voltage.

Test Data

Environmental Conditions

Temperature:	25 ° C
Relative Humidity:	50%
ATM Pressure:	1005mbar

The testing was performed by Charmi Peng on 2006-5-11.

Test Result: Pass

Test Mode: Transmitting

Reference Frequency: 464.5125 MHz, Limit: 2.5 ppm							
Environment Temperature	Power Supplied	Frequency Measure with Time Elapsed					
(°C)	(Vdc)	MCF (MHz)	PPM Error				
50	3.6	464.5122	-0.65				
40	3.6	464.5124	-0.22				
30	3.6	464.5125	0.00				
20	3.6	464.5125	0.00				
10	3.6	464.5124	-0.22				
0	3.6	464.5123	-0.43				
-10	3.6	464.5122	-0.65				
-20	3.6	464.5122	-0.65				
-30	3.6	464.5121	-0.86				

Frequency Stability versus Input Voltage

Reference Frequency: 462.6625 MHz, Limit: 2.5 ppm							
Power Supplied	Frequency Measure with Time Elapsed						
(Vdc)	Frequency (MHz)	PPM Error					
3.06	464.5124	-0.22					

§90.214 - TRANSIENT FREQUENCY BEHAVIOR

Applicable Standard

§90.214

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
TEKTRONIX	Digital Phosphor Oscilloscope	TDS 7104	B020518	2006-1-24	2007-1-24
HP	Modulation Analyzer	8901B	3438A05208	2006-2-28	2007-2-28
HP	Signal Generator	HP8657A	2849U00982	2006-2-28	2007-2-28

^{*} Statement of Traceability: Bay Area Compliance Lab Corp. (ShenZhen) attests that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

Test Procedure

TIA/EIA-603 2.2.19

Test Data

Environmental Conditions

Temperature:	25 ° C
Relative Humidity:	50%
ATM Pressure:	1005mbar

The testing was performed by Charmi Peng on 2006-5-15.

Test Result: Pass

Test Mode: Transmitting

For Narrowband

Operation Frequency (MHz)	Channel Separation (kHz)	Transient Period (ms)	Transient Frequency	Result	
464.5125	12.5	10	<+/-12.5 kHz		
		25	<+/-6.25 kHz	Pass	
		10	<+/-12.5 kHz		

Turn on



Turn off

